

FEATURES/BENEFITS

- 5V tolerant inputs and outputs
- Bus Hold feature holds last active state during 3-state operation
- $10\mu A$ I_{CCQ} quiescent power supply current
- Hot insertable
- 2.0V–3.6V V_{CC} supply operation
- $\pm 24mA$ balanced output drive
- Power down high impedance inputs and outputs
- Meets or exceeds JEDEC 36 specifications
- C speed performance: $t_{PD} = 4.1ns$
- Input hysteresis for noise immunity
- Operating temperature range:
-40°C to +85°C
- Latch-up performance exceeds 500mA
- ESD performance:
Human body model > 2000V
Machine model > 200V
- Packages available:
20-pin QSOP
20-pin SOIC

DESCRIPTION

The LCXH245 is an 8-bit non-inverting transceiver that has three-state outputs which are useful for bus-oriented applications. The Transmit/Receive (T/R) input determines the direction of data flow, either from A to B or B to A, and the Output Enable (\bar{OE}) inputs enables the selected port for output. The 3.3V LCXPlus family features low power, low switching noise, and fast switching speeds for low power portable applications as well as high-end, advanced workstation applications. 5V tolerant inputs and outputs allow this LCXPlus product to be used in mixed-voltage applications. Active Bus Hold feature on LCXH245 retains last valid logic state at unused or floating data inputs, thus eliminating the need for external pull-up resistors. To accommodate hot-plug or live insertion applications, this product is designed not to load an active bus when V_{CC} is removed.

Figure 1. Functional Block Diagram

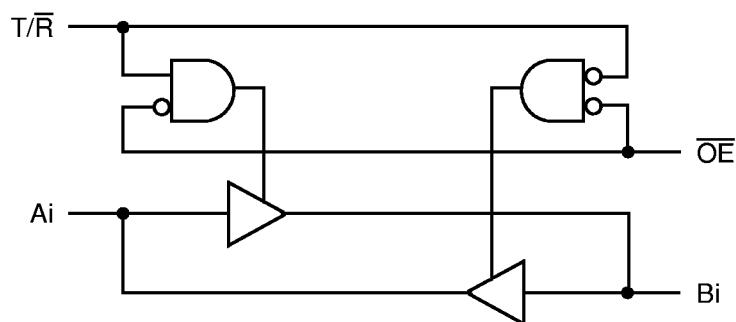
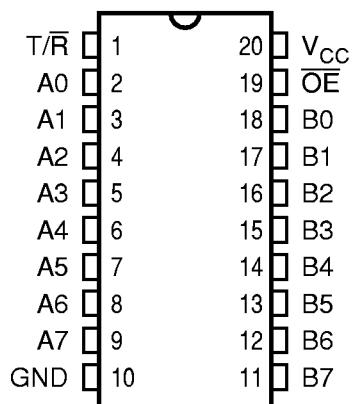


Figure 2. Pin Configuration

(All Pins Top View)

SOIC, QSOP

**Table 1. Pin Description**

Name	I/O	Description
A _i	I/O	Data Bus A
B _i	I/O	Data Bus B
T/R	I	Direction
OE	I	Three-State Output Enable

Table 2. Function Table

OE	T/R	A	B	Function
H	X	Hi-Z	Hi-Z	Disable
L	L	Output	Input	Bus B to Bus A
L	H	Input	Output	Bus A to Bus B

Table 3. Capacitance

Symbol	Pins	Typ	Unit	Conditions
C_{IN}	Input Capacitance	7.0	pF	$V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz$
$C_{I/O}$	I/O Capacitance	8.0	pF	$V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz$
C_{PD}	Power Dissipation Capacitance	20	pF	$V_{CC} = 3.3V, V_{IN} = 0V \text{ or } V_{CC} = 10MHz$

Note: Capacitance is characterized but not production tested.

Table 4. Absolute Maximum Ratings

Supply Voltage to Ground	-0.5V to 7.0V
DC Output Voltage V_{OUT}	
Outputs HIGH-Z	-0.5V to 7.0V
Outputs Active	-0.5V to $V_{CC} + 0.5V$
DC Input Voltage V_{IN}	-0.5V to 7.0V
DC Input Diode Current with $V_{IN} < 0$	-50mA
DC Output Diode Current	
$V_O < 0$	-50mA
$V_O > V_{CC}$	50mA
DC Output Source/Sink Current (I_{OH}/I_{OL})	$\pm 50mA$
DC Supply Current per Supply Pin	$\pm 100mA$
DC Ground Current per Ground Pin	$\pm 100mA$
T_{STG} Storage Temperature	-65°C to 150°C

Note: Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to QSI devices that result in functional or reliability type failures.

Table 5. Recommended Operating Conditions

Symbol	Parameter		Min	Max	Unit
V_{CC}	Supply Voltage, Operating		2.0	3.6	V
	Supply Voltage, Data Retention Only		1.5	3.6	
V_{IN}	Input Voltage		0	5.5	V
V_{OUT}	Output Voltage in Active State		0	V_{CC}	V
V_{OUT}	Output Voltage in "OFF" State		0	5.5	V
I_{OH}/I_{OL}	Output Current	$V_{CC} = 3.0 - 3.6V$	—	± 24	mA
		$V_{CC} = 2.7V$	—	± 12	
$\Delta t/\Delta v$	Input Transition Slew Rate		—	10	ns/V
T_A	Operating Free Air Temperature		-40	85	°C

Table 6. DC Electrical Characteristics Over Operating RangeIndustrial Temperature Range, $T_A = -40^\circ\text{C}$ to 85°C .

Symbol	Parameter	Test Conditions ⁽¹⁾		Min	Typ ⁽²⁾	Max	Unit
V_{IH}	Input HIGH Voltage	Logic HIGH for All Inputs		2.0	—	—	V
V_{IL}	Input LOW Voltage	Logic LOW for All Inputs		—	—	0.8	V
V_{OH}	Output HIGH Voltage	$V_{CC} = 2.7\text{V}$, $I_{OH} = -100\mu\text{A}$	$V_{CC} = 0.2$	—	—	—	V
		$V_{CC} = 2.7\text{V}$, $I_{OH} = -12\text{mA}$	2.2	—	—	—	
		$V_{CC} = 3.0\text{V}$, $I_{OH} = -18\text{mA}$	2.4	—	—	—	
		$V_{CC} = 3.0\text{V}$, $I_{OH} = -24\text{mA}$	2.2	—	—	—	
V_{OL}	Output LOW Voltage	$V_{CC} = 2.7\text{V}$, $I_{OL} = 100\mu\text{A}$	—	—	0.2	V	
		$V_{CC} = 2.7\text{V}$, $I_{OL} = 12\text{mA}$	—	—	0.4		
		$V_{CC} = 3.0\text{V}$, $I_{OL} = 16\text{mA}$	—	—	0.4		
		$V_{CC} = 3.0\text{V}$, $I_{OL} = 24\text{mA}$	—	—	0.5		
ΔV_T	Input Hysteresis ⁽³⁾	$V_{TLH} - V_{THL}$ for All Inputs		—	150	—	mV
$ I_{OZ} $	Off-State Output ⁽³⁾ Current (Hi-Z)	$V_{CC} = 3.6\text{V}$, $V_O = 0\text{V}$,	—	—	1	—	μA
V_{IK}	Input Clamp Voltage	$V_{CC} = 2.7\text{V}$, $I_{IN} = -18\text{mA}$	—	—	-0.7	-1.2	V
I_I	Input Leakage Current	$V_I = 0\text{V}$, $V_I = 5.5\text{V}$	—	—	—	± 1.0	μA
$ I_{IBH} $	Input Current Input HIGH or LOW Bus Hold Inputs ^(3,5)	$V_{CC} = 3.6\text{V}$ $V_{IN} = 0\text{V}$ or $V_{IN} = V_{CC}$	—	—	—	50	μA
		$V_{CC} = 3.6\text{V}$, $0.8 \leq V_{IN} \leq 2.0\text{V}$	—	—	—	500 ⁽⁶⁾	μA
I_{BHH}	Bus Hold Sustaining Current	$V_{CC} = 3.3\text{V}$	$V_{IN} = 2.0\text{V}$	-75	—	—	μA
I_{BHL}	Bus Hold Inputs		$V_{IN} = 0.8\text{V}$	+75	—	—	μA
I_{OFF}	Power Off Leakage	$V_{CC} = 0\text{V}$, V_I or $V_O = 5.5\text{V}$		—	—	10	μA

Notes:

1. For conditions shown as Min. or Max. use appropriate value specified under Recommended Operating Conditions for the applicable device type.
2. Typical values are at $V_{CC} = 3.3\text{V}$ and $T_A = 25^\circ\text{C}$.
3. These parameters are guaranteed by characterization, but not production tested.
4. Not more than one output should be tested at one time. Duration of test should not exceed one second.
5. Pins with Bus Hold are identified in the Pin Description.
6. An external driver must provide at least $|I_{BH}|$ during transition to guarantee that the Bus Hold input will change state.

Table 7. Power Supply Characteristics

Symbol	Parameter	Test Conditions ⁽¹⁾		Typ ⁽²⁾	Max	Unit
I_{CC}	Quiescent Power Supply Current	$V_{CC} = 3.6V$, Freq = 0 $V_{IN} = GND$ or V_{CC}		0.1	10	μA
ΔI_{CC}	Supply Current per Input @ TTL HIGH ⁽³⁾	$V_{CC} = 3.6V$	Control Inputs	2.0	30	μA
		$V_{IN} = V_{CC} - 0.6V$, Freq = 0	Bus Hold Input	—	500	
I_{CCD}	Supply Current per Input per MHz ⁽⁴⁾	$V_{CC} = 3.6V$, Outputs Open One Bit Toggling @ 50% Duty Cycle $xOE = GND$		50	75	$\mu A/ MHz$
I_C	Total Power Supply Current ⁽⁶⁾	$V_{CC} = 3.6V$, Outputs Open One Bit Toggling @ 50% Duty Cycle $xOE = GND$, $f = 10MHz$	$V_{IN} = V_{CC} - 0.6V$ $V_{IN} = GND$	0.5 ⁽⁵⁾	1.0 ⁽⁵⁾	mA
		$V_{CC} = 3.6V$, Outputs Open Eight Bits Toggling @ 50% Duty Cycle $xOE = GND$, $f = 2.5MHz$	$V_{IN} = V_{CC} - 0.6V$ $V_{IN} = GND$	1.0 ⁽⁵⁾	3.5 ⁽⁵⁾	mA

Notes:

- For conditions shown as Min. or Max., use the appropriate values specified under Recommended Operating Conditions for applicable device type.
- Typical values are at $V_{CC} = 3.3V$, $25^\circ C$ ambient.
- Per TTL driven input. All other inputs at V_{CC} or GND.
- This parameter is not directly testable, but is derived for use in total power supply calculations.
- Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed by design but not tested.
- $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$.
 $I_C = I_{CCQ} + \Delta I_{CC} D_H N_T + I_{CCD} f N_O$.
 I_{CCQ} = Quiescent Current (I_{CCL} , I_{CCH} , and I_{CCZ}).
 ΔI_{CC} = Power Supply Current for a TTL-High Input ($V_{IN} = V_{CC} - 0.6V$).
 D_H = Duty Cycle for TTL High Inputs.
 N_T = Number of TTL High Inputs.
 I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL).
 f = Average Switching Frequency per Output.
 N_O = Number of Outputs Switching.

Table 8. Dynamic Switching Characteristics⁽¹⁾

Symbol	Parameter	Conditions	V_{CC} (V)	$T_A = 25^\circ C$	Units
				Typical	
V_{OLP}	Quiet Output Dynamic Peak V_{OL}	$C_L = 50pF$, $V_{IH} = 3.3V$, $V_{IL} = 0V$	3.3	0.8	V
V_{OLV}	Quiet Output Dynamic Valley V_{OL}	$C_L = 50pF$, $V_{IH} = 3.3V$, $V_{IL} = 0V$	3.3	0.8	V

Note:

- Characterized but not production tested.

Table 9. Switching Characteristics Over Operating RangeIndustrial Temperature Range, $T_A = -40^{\circ}\text{C}$ to 85°C . $C_{\text{LOAD}} = 50\text{pF}$, $R_{\text{LOAD}} = 500\Omega$ unless otherwise noted.

Symbol	Description ⁽¹⁾	H245				H245C		Unit	
		$V_{\text{CC}} = 3.3 \pm 0.3\text{V}$		$V_{\text{CC}} = 2.7\text{V}^{(2)}$		$V_{\text{CC}} = 3.3 \pm 0.3\text{V}$			
		Min	Max	Min	Max	Min	Max		
t_{PHL}	Propagation Delay Ai to Bi	1.5	7.0	1.5	8.0	1.5	4.1	ns	
t_{PLH}									
t_{PZH}	Output Enable Time OE to A/B	1.5	8.5	1.5	9.5	1.5	5.8	ns	
t_{PZL}									
t_{PHZ}	Output Disable Time ⁽²⁾ OE to A/B	1.5	7.5	1.5	8.5	1.5	4.8	ns	
t_{PZL}									
t_{PZH}	Output Enable Time ⁽²⁾ $\text{T}/\bar{\text{R}}$ to A/B	1.5	8.5	1.5	9.5	1.5	5.8	ns	
t_{PZL}									
t_{PHZ}	Output Disable Time ⁽²⁾ $\text{T}/\bar{\text{R}}$ to A/B	1.5	7.5	1.5	8.5	1.5	4.8	ns	
t_{PLZ}									
$t_{\text{SK(O)}}$	Output Skew ⁽³⁾	—	0.5	—	—	—	0.5	ns	

Notes:

1. Minimums guaranteed but not production tested. See test circuit and waveforms.
2. Guaranteed by characterization.
3. Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by characterization but not production tested.

TEST CIRCUIT AND WAVEFORMS

Figure 3. Test Circuit

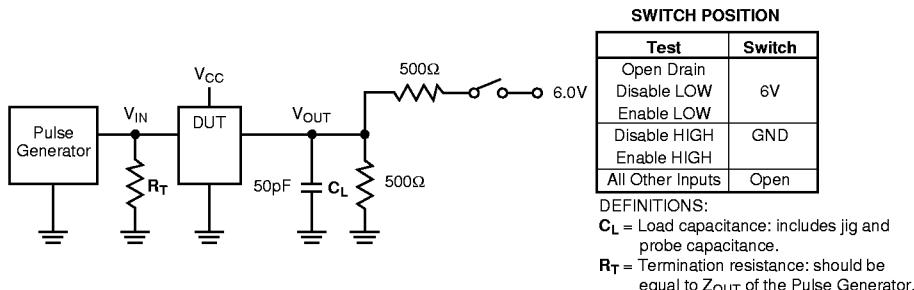


Figure 4. Setup, Hold, and Release Timing

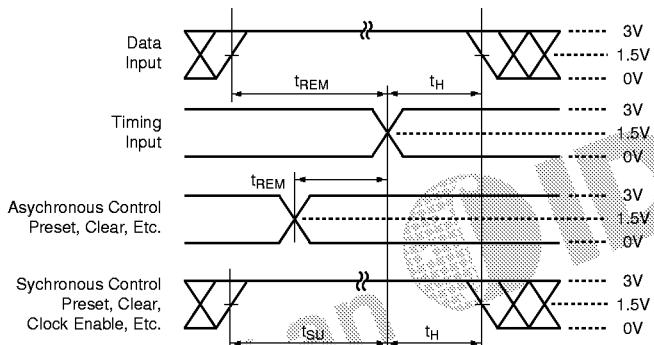


Figure 5. Enable and Disable Timing

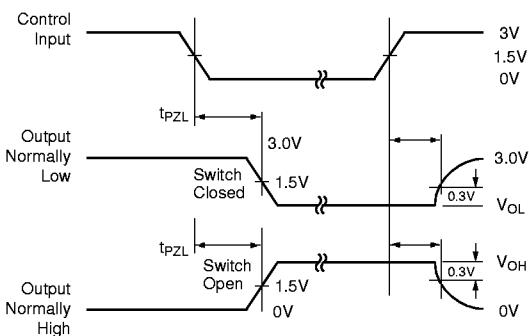


Figure 6. Pulse Width

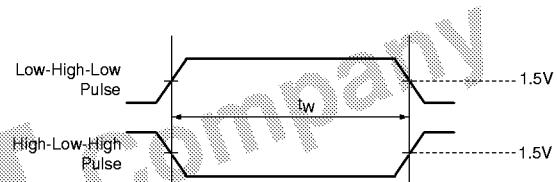
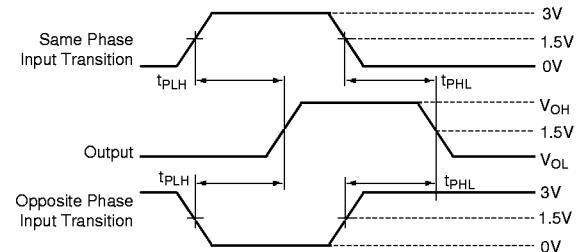


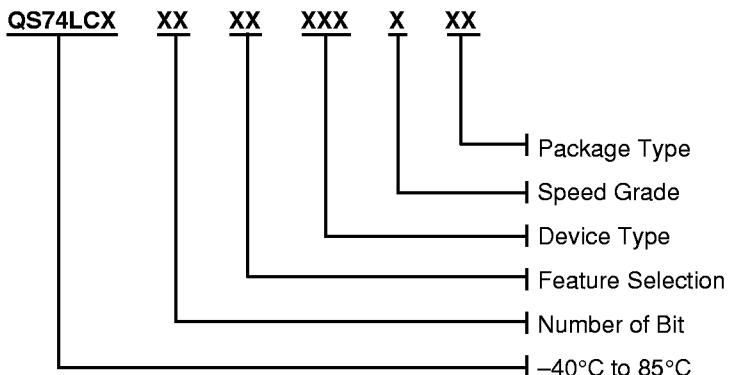
Figure 7. Propagation Delay



Notes:

1. Input Control Enable = LOW and Input Control Disable = HIGH.
2. Pulse Generator for All Pulses: Rate $\leq 1.0\text{MHz}$;
 $Z_{OUT} \leq 50\Omega$; $t_F, t_R \leq 2.5\text{ns}$.

ORDERING INFORMATION



Device Type:

245

Speed Grades:

Blank – Standard
C

Package Type:

20-pin QSOP
20-pin SOIC

Feature Selection:

H – Bus Hold

Number of Bit:

Blank – 8-Bit

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